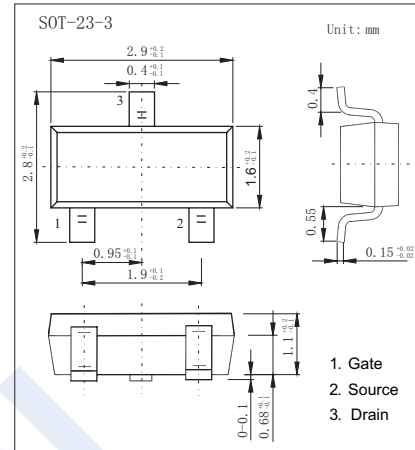


N-Channel MOSFET

BSS123

■ Features

- $V_{DS} = 100V$
- $I_D = 0.17 A$ ($V_{GS} = 10V$)
- $R_{DS(ON)} < 6 \Omega$ ($V_{GS} = 10V$)
- $R_{DS(ON)} < 10 \Omega$ ($V_{GS} = 4.5V$)
- ESD Protected 2KV HBM



■ Absolute Maximum Ratings $T_a = 25^\circ C$

| Parameter | Symbol | Rating | Unit |
|---|-----------------|------------|---------------|
| Drain-Source Voltage | V_{DS} | 100 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | |
| Continuous Drain Current | I_D | 0.17 | A |
| Pulsed Drain Current | I_{DM} | 0.68 | |
| Power Dissipation | P_D | 0.36 | W |
| Derate Above $25^\circ C$ | | 2.8 | $mW/^\circ C$ |
| Thermal Resistance, Junction-to-Ambient | $R_{\theta JA}$ | 350 | $^\circ C/W$ |
| Junction Temperature | T_J | 150 | $^\circ C$ |
| Storage Temperature Range | T_{stg} | -55 to 150 | |

N-Channel MOSFET

BSS123

■ Electrical Characteristics Ta = 25°C

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
|---------------------------------------|---------------------|--|------|-----|------|------|
| Drain-Source Breakdown Voltage | V _{DSS} | I _D =250 μA, V _{GS} =0V | 100 | | | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =100V, V _{GS} =0V | | | 1 | μA |
| | | V _{DS} =100V, V _{GS} =0V, T _J =55°C | | | 60 | |
| Gate-Body Leakage Current | I _{GSS} | V _{DS} =0V, V _{GS} =±20V | | | ±10 | |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} =V _{GS} , I _D =1mA | 0.8 | | 2.8 | V |
| Static Drain-Source On-Resistance | R _{DS(on)} | V _{GS} =10V, I _D =0.17A | | | 6 | Ω |
| | | V _{GS} =10V, I _D =0.17A, T _J =125°C | | | 12 | |
| | | V _{GS} =4.5V, I _D =0.17A | | | 10 | |
| On State Drain Current | I _{D(ON)} | V _{GS} =10V, V _{DS} =5V | 0.68 | | | A |
| Forward Transconductance | g _{FS} | V _{DS} =10V, I _D =0.17A | 0.08 | | | S |
| Input Capacitance | C _{iss} | V _{GS} =0V, V _{DS} =25V, f=1MHz | | 73 | | pF |
| Output Capacitance | C _{oss} | | | 7 | | |
| Reverse Transfer Capacitance | C _{rss} | | | 3.4 | | |
| Gate Resistance | R _g | V _{GS} =15mV, f=1MHz | | 2.2 | | Ω |
| Total Gate Charge | Q _g | V _{GS} =10V, V _{DS} =30V, I _D =0.22A | | 1.8 | 2.5 | nC |
| Gate Source Charge | Q _{gs} | | | 0.2 | | |
| Gate Drain Charge | Q _{gd} | | | 0.3 | | |
| Turn-On DelayTime | t _{d(on)} | V _{DD} = 30 V, I _D = 0.28 A, V _{GS} = 10 V, R _{GEN} = 6 Ω | | 1.7 | 3.4 | ns |
| Turn-On Rise Time | t _r | | | 9 | 18 | |
| Turn-Off DelayTime | t _{d(off)} | | | 17 | 31 | |
| Turn-Off Fall Time | t _f | | | 2.4 | 5 | |
| Body Diode Reverse Recovery Time | t _{rr} | | | 11 | | |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = 0.17A, di/dt= 100A/μs | | 3 | | nC |
| Maximum Body-Diode Continuous Current | I _S | | | | 0.17 | A |
| Diode Forward Voltage | V _{SD} | I _S =0.34A, V _{GS} =0V | | | 1.3 | V |

Note.: Pulse Test: Pulse Width ≤ 300 us, Duty Cycle ≤ 2.0%

■ Marking

| | |
|---------|----|
| Marking | SA |
|---------|----|

N-Channel MOSFET BSS123

■ Typical Characteristics

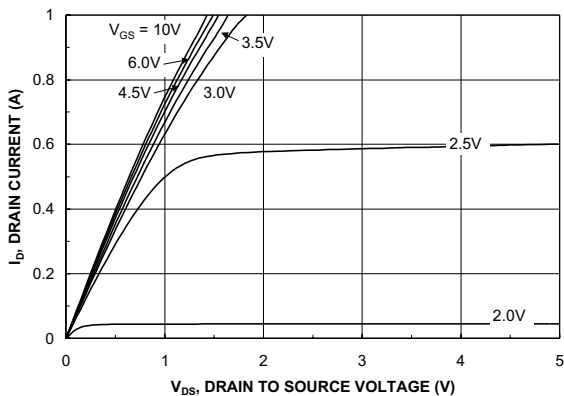


Figure 1. On-Region Characteristics.

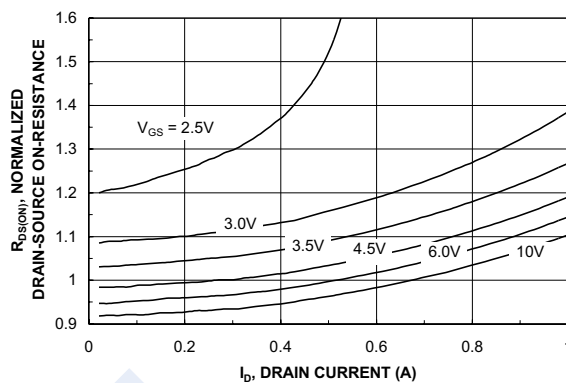


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

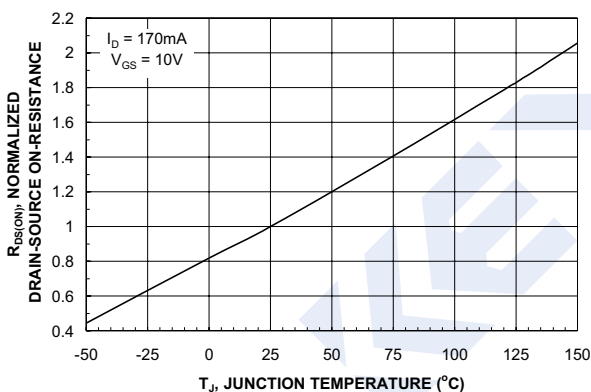


Figure 3. On-Resistance Variation with Temperature.

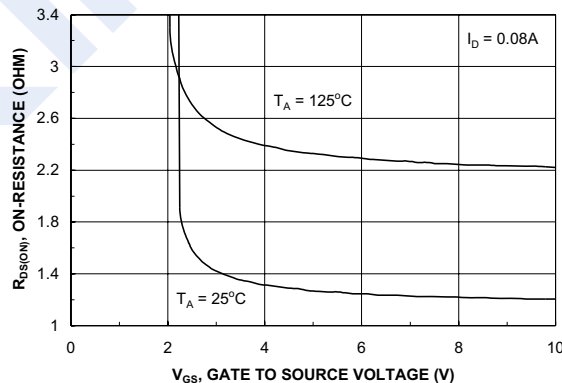


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

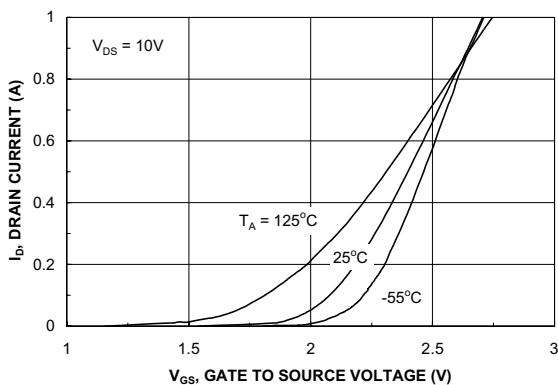


Figure 5. Transfer Characteristics.

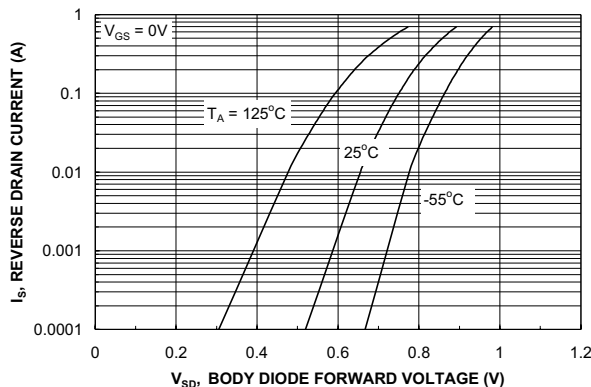


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

N-Channel MOSFET BSS123

Typical Characteristics

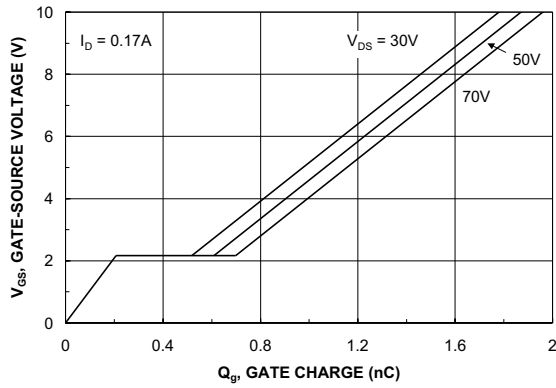


Figure 7. Gate Charge Characteristics.

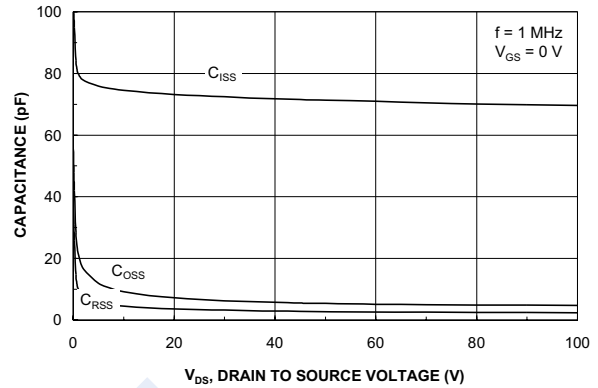


Figure 8. Capacitance Characteristics.

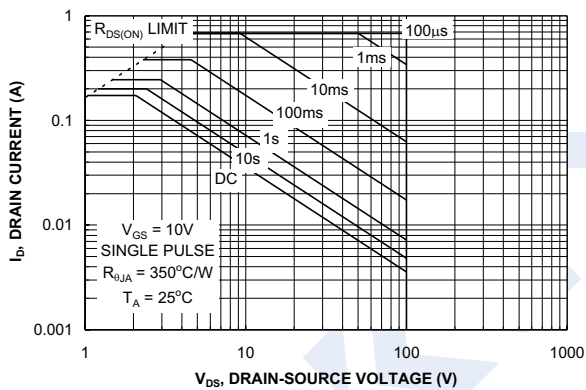


Figure 9. Maximum Safe Operating Area.

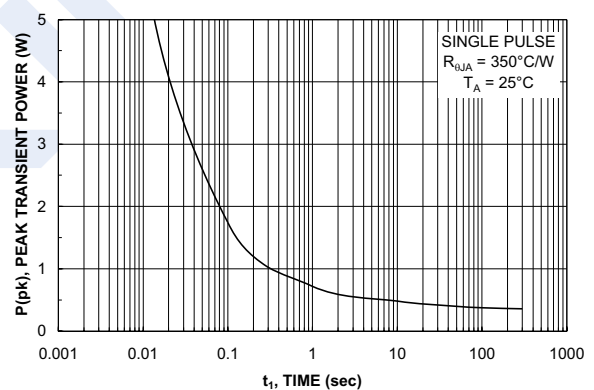


Figure 10. Single Pulse Maximum Power Dissipation.

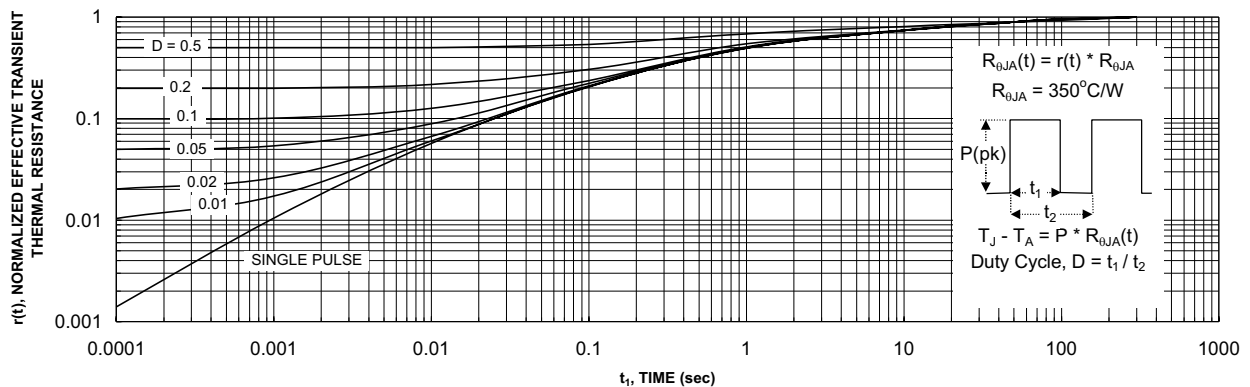


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1a.
Transient thermal response will change depending on the circuit board design.